Features

- ullet Broadband, Minimum Ripple Cascadable 50 Ω Gain Block
- 8.0 ± 0.2 dB Typical Gain Flatness from 0.1 to 4.0 GHz
- 3 dB Bandwidth: 0.1 to 6.0 GHz
- Low VSWR: ≤ 1.5:1 from 0.1 to 4.0 GHz
- 11.5 dBm Typical P_{1dB} at 1.0 GHz

Description

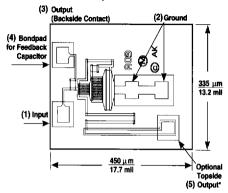
The MSA is a high performance silicon bipolar Monolithic Microwave Integrated Circuit (MMIC) chip. This MODAMPTM MMIC is designed for very wide bandwidth industrial and military applications that require flat gain and low VSWR.

The MODAMP MSA-series is fabricated using a 10 GHz ft. 25 GHz f_{MAX}, silicon bipolar MMIC process which utilizes nitride self-alignment, ion implantation and gold metallization to achieve excellent uniformity, performance and reliability. The use of an external bias resistor for temperature and current stability also allows bias flexibility.

The recommended assembly procedure is gold-eutectic die attach at 400°C and either wedge or ball bonding using 0.7 mil gold wire.

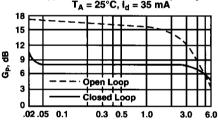
This chip is intended to be used with an external blocking capacitor completing the shunt feedback path (closed loop). Data sheet characterization is given for a 45 pF capacitor. Low frequency performance can be extended by using a larger valued capacitor1.

Chip Outline¹



Unless otherwise specified, tolerances are ±13 µm/±0.5 mils. Chip thickness is 114 µm/4.5 mil Bond Pads are 41 µm/1.6 mil typical on each side. *Output contact is normally made by die attaching the backside of the die.

Typical Power Gain vs. Frequency



Frequency, GHz

Electrical Specifications², T_A = 25°C

Unless otherwise noted, performance is for a MSA-0900 used with an external 45 pF capacitor. See bonding diagram.

Symbol	Parameters and Test Conditions ³ : I_d = 35 mA, Z_O = 50 Ω				Тур.	Max.
G _P	Power Gain (IS ₂₁ I ²)	f = 0.1 GHz	dB		8.0	
ΔG _P	Gain Flatness ⁴	f = 0.1 to 4.0 GHz	dB		±0.2	
f _{3 dB}	3 dB Bandwidth ^{4,5}		GHz		6.0	
VSWR	Input VSWR	f = 0.1 to 4.0 GHz			1.4:1	
	Output VSWR	f = 0.1 to 4.0 GHz			1.5:1	
P _{1 dB}	Output Power @ 1 dB Gain Compression	f = 1.0 GHz f = 4.0 GHz	dBm		11.5 6.5	
NF	50 Ω Noise Figure	f = 1.0 GHz f = 4.0 GHz	dB		6.0 6.5	
IP ₃	Third Order Intercept Point	f = 1.0 GHz	dBm		23.0	
t _D	Group Delay	f = 1.0 GHz	psec		60	
V _d	Device Voltage		٧	7.0	7.8	8.6
dV/dT	Device Voltage Temperature Coefficient		mV/°C		-16.0	

- See Application Note, AN-S009: MODAMPTM Silicon MMIC Chip Use for additional information.
 - The recommended operating current range for this device is 25 to 45 mA. Typical performance as a function of current is on the following page.

 - RF performance of the chip is determined by packaging and testing 10 devices per wafer.

 The value is the expected achievable performance for the MSA-0900 used with an external 45 pF capacitor mounted in a 100 mil stripline package
 - Referenced from 0.1 GHz gain (G_P).

Part Number Ordering Information

Absolute Maximum Ratings

Parameter	Absolute Maximum ¹				
Device Current	80 mA				
Power Dissipation ^{2, 3}	750 mW				
RF Input Power	+13 dBm				
Junction Temperature	200°C				
Storage Temperature	-65 to 200°C				
Thermal Resistance ^{2,4} : θ _{ic} = 70°C/W					

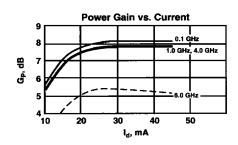
Notes:

- 1. Permanent damage may occur if any of these limits are exceeded.
- TMOUNTING SURFACE = 25°C.
 Derate at 14 mW/°C for TMOUNTING SURFACE > 148°C.
- 4. The small spot size of the technique used results in a higher, though more accurate, determination of $\boldsymbol{\theta}_{ic}$ than do alternate methods.

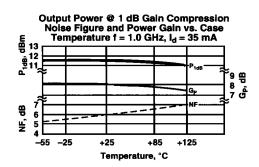
Typical Performance, $T_A = 25^{\circ}C$

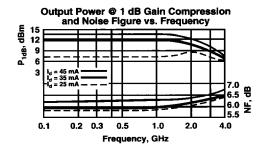
(Unless otherwise noted)

Note: Unless otherwise noted, performance is for a MSA-0900 used with an external 45 pF capacitor mounted in a 100 mil stripline package. See bonding diagram.



Devices Per Tray Part Number MSA-0900-GP2 10 MSA-0900-GP4 100 MSA-0900-GP6 Up to 300

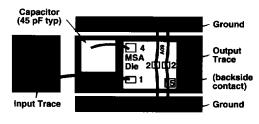




Typical Biasing Configuration

RFC (Optional) $V_{cc} \ge 12$ $V_{cc} \ge 12$ $V_{cc} \ge 12$ $V_{cc} \ge 12$ $V_{cc} \ge 12$

Bonding Diagram



Numbers refer to pin contacts listed on the Chip Outline.

Typical Freq.	Scattering Parame		eters ^{5,6} : $Z_0 = 50 \Omega$ S_{21}			S ₁₂			T _A = 1	35 mA	
GHz	Mag	Ang	dB	Mag	Ang	dB	Mag	Ang	Mag	Ang	k
0.02	.32	-107	10.8	3.48	151	-13.9	.203	17	.32	-106	0.83
0.05	.22	-143	8.6	2.70	164	-13.6	.209	6	.22	-142	1.09
0.1	.11	-144	8.2	2.57	171	-13.3	.215	3	.11	-142	1.16
0.2	.10	-160	8.1	2.54	172	-13.5	.211	1	.11	-158	1.19
0.4	.10	-171	8.1	2.54	175	-13.4	.215	2	.10	-166	1.18
0.6	.09	-170	8.1	2.55	166	-13.3	.216	1	.10	-166	1.18
0.8	.08	-171	8.2	2.57	162	-13.3	.216	1	.11	-166	1.17
1.0	.08	-170	8.3	2.59	158	-13.1	.220	1	.11	-167	1.15
1.5	.07	-166	8.6	2.68	147	-13.1	.221	1	.14	-172	1.12
2.0	.07	-138	8.9	2.80	136	-12.6	.234	1	.15	-172	1.07
2.5	.08	-131	9.3	2.92	126	-12.6	.236	1	.18	179	1.04
3.0	.12	-119	9.6	3.01	112	-12.0	.250	1	.21	171	0.99
3.5	.17	-125	9.6	3.02	95	-11.8	.256	-1	.22	157	0.97
4.0	.22	-132	9.1	2.86	78	-11.5	.265	-3	.19	144	0.96
4.5	.27	-140	8.4	2.64	63	-11.5	.265	-5	.16	138	0.97
5.0	.32	-149	7.5	2.36	50	-11.4	.268	-6	.12	138	1.00
5.5	.34	-154	6.4	2.09	38	-11.3	.272	-6	.10	162	1.02
6.0	.36	-158	5.3	1.84	29	-11.3	.272	-6	.10	-166	1.07
6.5	.38	-158	4.2	1.62	22	-11.4	.271	-6	.16	-151	1.12
7.0	.39	-157	3.2	1.45	15	-11.5	.267	-6	.23	-147	1.17

Notes: 5. S-parameters are de-embedded from 100 mil BeO package measured data using the package model found in the DEVICE MODELS section.

6. S-parameter data assumes an external 45 pF capacitor. Low frequency performance can be exended using a larger valued capacitor.